Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/633,708	CHEN ET AL.	
Examiner	Art Unit	
Ling-Siu Choi	1713	

	SEARCHED				
Class	Subclass	Date	Examiner		
526	346	5/25/2005	LSC		
510	175		İ		
136	263				
	254				
	261				
	- W				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NO' (INCLUDING SEARCH)
	DATE	EXMR
West	5/25/2005	LSC
conjugated polymer or poly(vinylene phenylene)-metal-chelate or crown ether-photoelecric device		
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